SN74ALVCH373 OCTAL TRANSPARENT D-TYPE LATCH WITH 3-STATE OUTPUTS

SCES116E - JULY 1997 - REVISED JANUARY 2000

- EPIC™ (Enhanced-Performance Implanted CMOS) Submicron Process
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- Package Options Include Plastic Small-Outline (DW), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) Packages

(TOP VIEW) OE 20 🛮 V_{CC} 1Q [2 19 🛮 8Q 1D 🛮 3 18 8D 2D **∏** 4 17 **∏** 7D 2Q **∏** 5 16 7Q 3Q **∏** 6 15 1 6Q 3D **∏** 7 14 \ 6D 13 T 5D 4D **1**8 4Q 🛮 9 12 🛮 5Q GND **1** 10 11 **∏** LE

DGV. DW. OR PW PACKAGE

description

This octal transparent D-type latch is designed for 1.65-V to 3.6-V V_{CC} operation.

The SN74ALVCH373 is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels set up at the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH373 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each latch)

	INPUTS	ОИТРИТ	
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q ₀
Н	Χ	Χ	Z



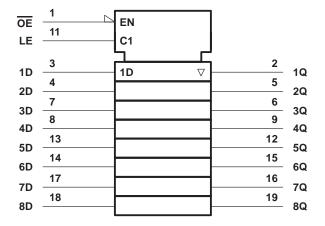
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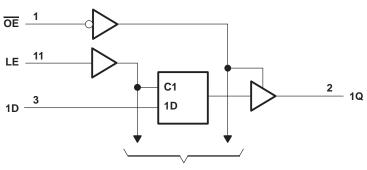
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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	
Input voltage range, V _I (see Note 1)	
Output voltage range, VO (see Notes 1 and 2)	0.5 V to V _{CC} + 0.5 V
Input clamp current, $I_{ K }(V_{ C } < 0)$	—50 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Continuous output current, IO	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ _{JA} (see Note 3): [DGV package 92°C/W
	DW package 58°C/W
F	PW package 83°C/W
Storage temperature range, T _{stg}	

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.



recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
VCC	Supply voltage		1.65	3.6	V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	0.65 × V _{CC}			
V_{IH}	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2	3.6 0.35 × V _{CC} 0.7 0.8 V _{CC} -4 -12 -12 -24 4 12 12 24 5		
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		$0.35 \times V_{CC}$	3.6 V V 35 × V _{CC} 0.7 V 0.8 V _{CC} V V _{CC} V -4 -12 -12 -24 4 12 mA	
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7		
V _I		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		
VI	Input voltage		0	Vcc	V	
VO	Output voltage		0	Vcc	V	
		V _{CC} = 1.65 V		-4		
lou	High lovel output ourrent	V _{CC} = 2.3 V		-12		
$V_{O} \qquad \text{Output voltage} \\ I_{OH} \qquad \text{High-level output current} \qquad \qquad \frac{V_{CC} = 1.65 \text{ V}}{V_{CC} = 2.3 \text{ V}} \\ V_{CC} = 2.7 \text{ V}$		-12	mA			
		V _{CC} = 3 V		-24		
		$V_{CC} = 1.65 \text{ V}$		4		
lai	Low-level output current	V _{CC} = 2.3 V		12	^	
lOL		$V_{CC} = 2.7 \text{ V}$		12	1 mA	
		V _{CC} = 3 V		24		
Δt/Δν	Input transition rise or fall rate			5	ns/V	
TA	Operating free-air temperature		-40	85	°C	

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER	TEST CO	ONDITIONS	vcc	MIN	TYP [†]	MAX	UNIT		
		I _{OH} = -100 μA		1.65 V to 3.6 V	V _{CC} -0.	2				
	$I_{OH} = -4 \text{ mA}$		1.65 V	1.2						
Vон				2.3 V	1.7			V		
		I _{OH} = -12 mA		2.7 V	2.2					
				3 V	2.4					
		I _{OH} = -24 mA		3 V	2					
		I _{OL} = 100 μA		1.65 V to 3.6 V			0.2			
		I _{OL} = 4 mA		1.65 V			0.45			
		I _{OL} = 6 mA		2.3 V			0.4	V		
VOL		1 40 mA		2.3 V			0.7	V		
		IOL = 12 MA		2.7 V			0.4			
I _{OL} = 24 mA				3 V			0.55			
Ιį		$V_I = V_{CC}$ or GND		3.6 V			±5	μΑ		
		V _I = 0.58 V		1.65 V	25					
		V _I = 1.07 V		1.65 V	-25					
		V _I = 0.7 V		2.3 V	45					
I _I (hold)		V _I = 1.7 V		2.3 V	-45			μΑ		
` ´		V _I = 0.8 V		3 V	75					
		V _I = 2 V		3 V	-75					
		$V_{\parallel} = 0 \text{ to } 3.6 \text{ V}^{\ddagger}$		3.6 V			±500			
loz		$V_O = V_{CC}$ or GND		3.6 V			±10	μΑ		
			I _O = 0	3.6 V			20	μΑ		
			Other inputs at V _{CC} or GND	3 V to 3.6 V		-	750	μΑ		
	_			3.3 V				pF		
Co		V _O = V _{CC} or GND		3.3 V				pF		

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

		V _{CC} = 1.8		V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _W	Pulse duration, LE high	3.8		3.3		3.3		3.3		ns
t _{su}	Setup time, data before LE↓	1.3		0.5		0.5		0.5		ns
th	Hold time, data after LE↓	0.5		1.3		1.7		1.2		ns



[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C. ‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

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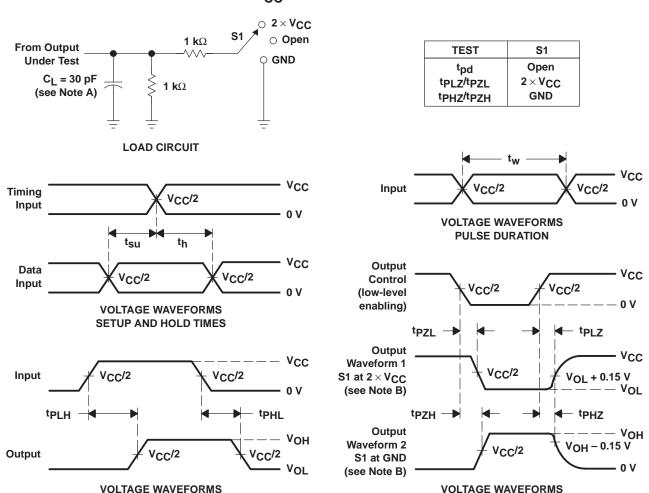
switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		1.8 V 5 V	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		$CC = 2.5 \text{ V} \\ \pm 0.2 \text{ V}$ $V_{CC} = 2.7 \text{ V}$ $V_{CC} = 3.3 \text{ V} \\ \pm 0.3 \text{ V}$		V _{CC} = 3.3 V ± 0.3 V		UNIT
	(INFOT)	(001F01)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX			
^t pd	D	Q	1.7	6.3	1	4		4	1	3.6	no		
	LE		2	6.1	1	3.8		3.7	1	3.3	ns		
t _{en}	ŌĒ	Q	3.4	8.3	1.9	5.4		5.4	1.6	4.8	ns		
t _{dis}	ŌE	Q	1.6	7	1	4.4		4.4	1	4.4	ns		

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER			TEST	V _{CC} = 1.8 V	V _{CC} = 2.5 V	V _{CC} = 3.3 V	UNIT	
	. ,		CONDITIONS	TYP	TYP	TYP		
C .	Power dissipation capacitance	Outputs enabled	C _L = 0,	31	33	37	pF	
Cpd	per latch	Outputs disabled	f = 10 MHz	7	7	9	рг	

PARAMETER MEASUREMENT INFORMATION $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$



- NOTES: A. C_I includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \ \Omega$, $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.

ENABLE AND DISABLE TIMES

- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.

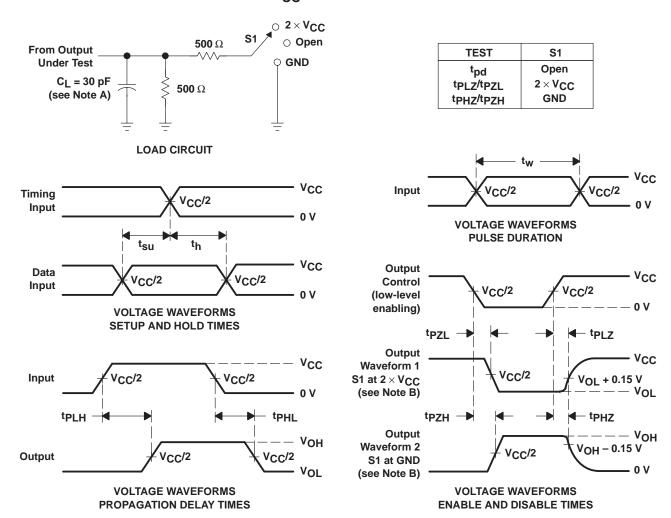
PROPAGATION DELAY TIMES

- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$

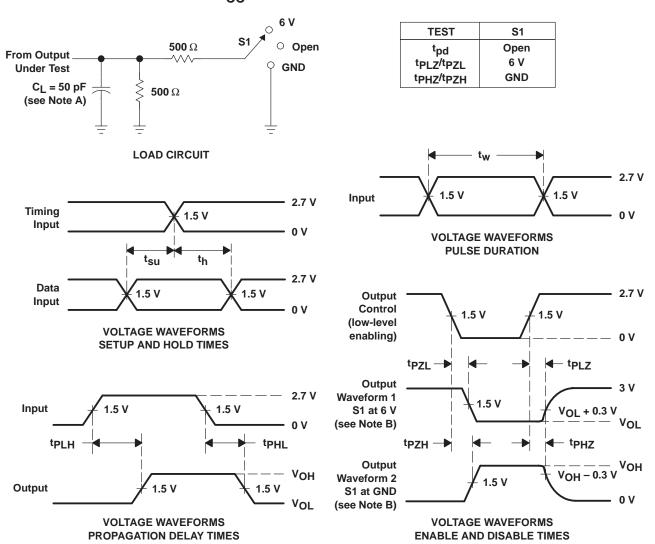


NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \ \Omega$, $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.7 V AND 3.3 V \pm 0.3 V



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpl 7 and tpH7 are the same as tdis.
- F. tpZL and tpZH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms



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